

Search Notes

Application/Control No.

10/563,174

Examiner

Hau V. Phan

Applicant(s)/Patent under
Reexamination

REFSUM, BJORN

Art Unit

3618

SEARCHED

Class	Subclass	Date	Examiner
280	655 655.1 43.315	6/4/2007	HP
	47.26		
16	113.1	6/4/2007	HP
	114.1		
	405		
190	115	6/4/2007	HP
	18A		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR